


Search Notes 	Application/Control No. 10064095	Applicant(s)/Patent Under Reexamination HUNG, CHIH-WEI
	Examiner MEIYA LI	Art Unit 2811

SEARCHED			
Class	Subclass	Date	Examiner
257	215,233,292,297,396,436,461,E27.131-E27.133,E31.084		
438	73,84,144,308,424		
250	214.1,208.1	12/15/09	ML

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	12/15/09	ML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner